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Pages 1 to 16

**CAPACITORS, FIXED, D.C. SELF-HEALING,  
METALLISED POLYESTER FILM DIELECTRIC,  
BASED ON TYPE MKT  
ESA/SCC Detail Specification No. 3006/019**



**space components  
coordination group**

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		SCCG Chairman	ESA Director General or his Deputy
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		P1. Cover page		None
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		P8. Figure 2	: In the Table, Symbol 'C' corrected to 'L'	221479
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**APPENDICES (Applicable to specific Manufacturers only)**

None.



1. **GENERAL**

1.1 **SCOPE**

This specification details the ratings, physical and electrical characteristics, test and inspection data for Capacitors, Fixed, Metallised, Polyester Film Dielectric, based on Type MKT. It shall be read in conjunction with ESA/SCC Generic Specification No. 3006, the requirements of which are supplemented herein.

1.2 **RANGE OF COMPONENTS**

The range of capacitors covered by this specification is scheduled in Table 1(a).

1.3 **MAXIMUM RATINGS**

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the capacitors specified herein, are scheduled in Table 1(b).

1.4 **PARAMETER DERATING INFORMATION**

The parameter derating information applicable to the capacitors specified herein is shown in Figure 1.

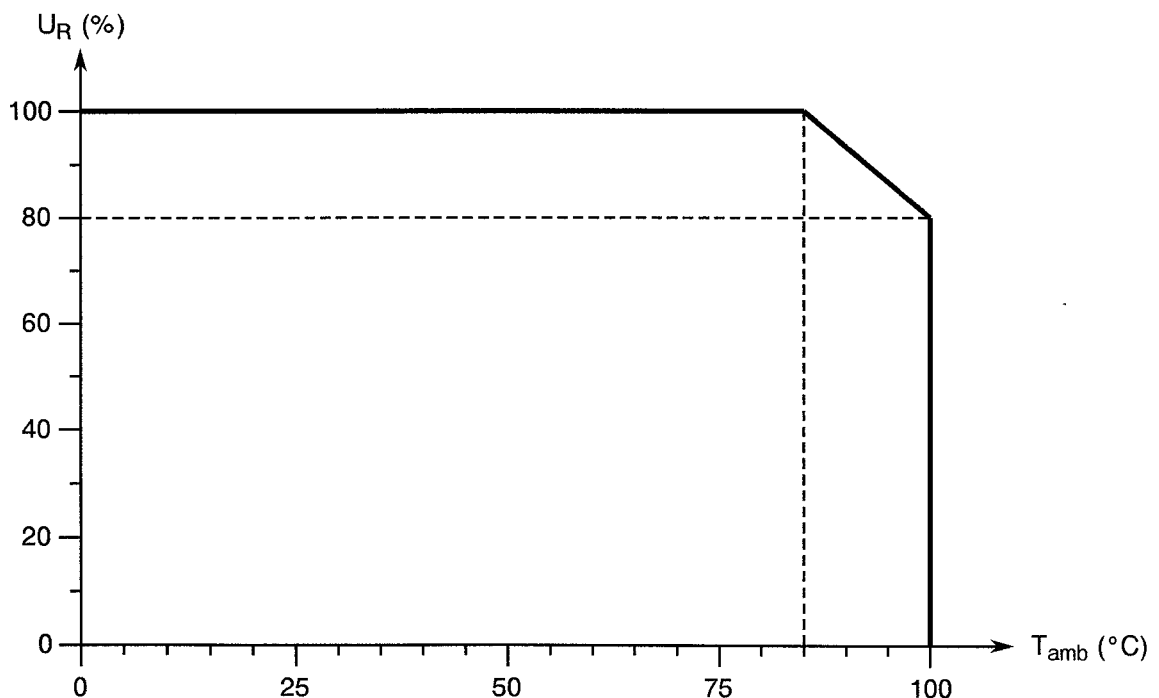
1.5 **PHYSICAL DIMENSIONS**

The physical dimensions of the capacitors specified herein are shown in Figure 2.

1.6 **FUNCTIONAL DIAGRAM**

The functional diagram for the capacitors specified herein is shown in Figure 3.

**FIGURE 1 - PARAMETER DERATING INFORMATION**



**Rated Voltage versus Ambient Temperature**

**TABLE 1(a) - RANGE OF COMPONENTS**

(1) Item No.	(2) Capacitance Value (C) ( $\mu$ F)	(3) d.c. Rated Voltage ( $U_R$ ) (V)	(4) Dimensions (mm)		(5) Weight (g)
			$\varnothing$ A Max.	B Max.	
01	0.47	50	7.4	18.5	1.6
02	0.68	50	7.4	18.5	1.6
03	1.0	50	8.4	18.5	2.2
04	1.0	50	9.4	18.5	2.6
05	1.5	50	9.4	18.5	2.6
06	2.2	50	9.4	21	2.6
07	3.3	50	10.7	21	2.9
08	4.7	50	10.7	21	2.9
09	6.8	50	12.7	21	4.1
10	10	50	13.7	21	6.0
11	0.10	100	7.4	18.5	1.6
12	0.15	100	7.4	18.5	1.6
13	0.22	100	8.4	18.5	2.2
14	0.33	100	8.4	18.5	2.2
15	0.47	100	8.4	18.5	2.2
16	0.68	100	8.4	18.5	2.2
17	1.0	100	8.4	21	2.5
18	1.5	100	8.4	21	2.5
19	2.2	100	9.4	21	2.9
20	3.3	100	10.7	21	3.3
21	4.7	100	11.7	21	3.6
22	6.8	100	10.7	34	5.4
23	10	100	12.7	34	8.0
24	22	100	15.7	34	11
25	47	100	21.7	34	23
26	100	100	29.7	34	30
27	0.10	160	7.4	18.5	2.2
28	0.15	160	7.4	18.5	2.2
29	0.22	160	8.4	18.5	2.6
30	0.33	160	8.4	18.5	2.6
31	0.47	160	8.4	21	2.9
32	0.68	160	9.4	21	3.6
33	1.0	160	10.7	21	4.8
34	1.5	160	11.7	21	5.1
35	2.2	160	12.7	21	5.8
36	3.3	160	11.7	34	9.5
37	4.7	160	12.7	34	11
38	6.8	160	14.7	34	17
39	10	160	16.7	34	19

**NOTES**

1. The capacitors have tolerances of  $\pm 5.0\%$ ,  $\pm 10\%$  and  $\pm 20\%$  for all values.

**TABLE 1(a) - RANGE OF COMPONENTS (CONT'D)**

(1) Item No.	(2) Capacitance Value (C) ( $\mu$ F)	(3) d.c. Rated Voltage ( $U_R$ ) (V)	(4) Dimensions (mm)		(5) Weight (g)
			$\varnothing$ A Max.	B Max.	
40	0.10	250	8.4	18.5	2.2
41	0.15	250	8.4	18.5	2.2
42	0.22	250	9.4	18.5	2.6
43	0.33	250	9.4	21	3.3
44	0.47	250	9.4	21	3.3
45	0.68	250	10.7	21	4.1
46	1.0	250	11.7	21	4.7
47	1.5	250	13.7	21	5.8
48	2.2	250	15.7	21	6.3
49	3.3	250	14.7	34	11
50	4.7	250	16.7	34	14
51	6.8	250	18.7	34	20
52	10	250	21.7	34	30
53	0.033	630	8.4	18.5	2.2
54	0.047	630	9.4	18.5	2.8
55	0.068	630	8.4	21	2.6
56	0.10	630	9.4	21	2.8
57	0.15	630	10.7	21	2.9
58	0.22	630	11.7	21	3.6
59	0.33	630	13.7	21	5.8
60	0.47	630	15.7	21	6.0
61	0.68	630	13.7	34	9.0
62	1.0	630	15.7	34	11
63	1.5	630	18.7	34	14.5
64	2.2	630	21.7	34	19
65	3.3	630	25.7	34	25
66	4.7	630	29.7	34	30
67	0.22	630	12.7	18.5	3.8
68	0.47	630	12.7	25	4.8

**NOTES**

1. The capacitors have tolerances of  $\pm 5.0\%$ ,  $\pm 10\%$  and  $\pm 20\%$  for all values.

**TABLE 1(b) - MAXIMUM RATINGS**

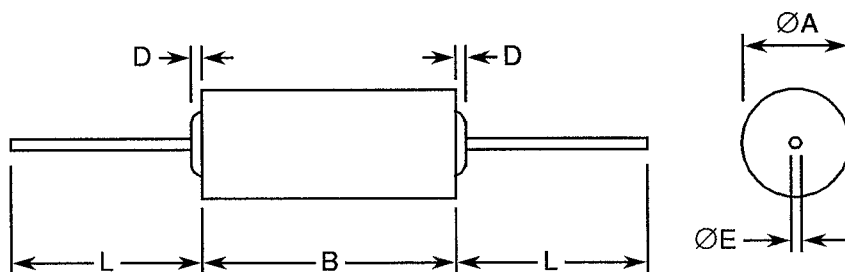
No.	Characteristics	Symbol	Maximum Ratings	Unit	Remarks
1	Rated Voltage d.c.	$U_R$	See Table 1(a)	V	Note 1
2	Rated Voltage a.c. (50/60 Hz)	$U_A$	35% of $U_R$	Vrms	
3	Operating Temperature Range	$T_{op}$	- 55 to + 100	°C	$T_{amb}$
4	Storage Temperature Range	$T_{stg}$	- 55 to + 100	°C	
5	Soldering Temperature	$T_{sol}$	+ 260	°C	Note 2

**NOTES**

1. At  $T_{amb} \leq +85^\circ\text{C}$ . For derating at  $T_{amb} > +85^\circ\text{C}$ , see Figure 1.
2. Duration 5 seconds maximum at a distance of not less than 6.0mm from the case and the same lead shall not be resoldered until 3 minutes have elapsed.

**FIGURE 2 - PHYSICAL DIMENSIONS**

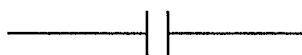
Symbol	Millimetres		Remarks
	Min.	Max.	
$\varnothing A$	Note 1		
B	Note 1		
D	-	1.50	
$\varnothing E$	0.59	0.65	Note 2
$\varnothing E$	0.75	0.88	Note 3
$\varnothing E$	0.95	1.05	Note 4
L	35.00	45.00	



**NOTES**

1. See Table 1(a) for dimensions.
2. For  $\varnothing A < 8.5\text{mm}$ .
3. For  $8.5\text{mm} \leq \varnothing A \leq 15\text{mm}$ .
4. For  $\varnothing A > 15\text{mm}$ .

**FIGURE 3 - FUNCTIONAL DIAGRAM**









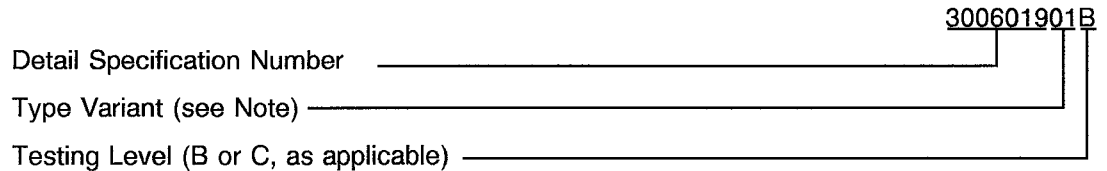


4.5.2 Lead Identification

Not applicable.

4.5.3 The SCC Component Number

The SCC Component Number shall be constituted and marked as follows:-



**N.B.**

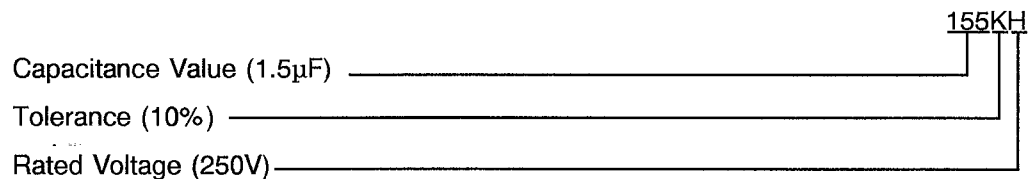
Marking of the Type Variant Number is mandatory. No further reference to type variants is made in this specification.

4.5.4 Electrical Characteristics and Ratings

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Capacitance Value.
- (b) Tolerance.
- (c) Rated Voltage.

The information shall be constituted and marked as follows:-



4.5.4.1 Capacitance Values

Capacitance values shall be coded as follows. The unit quantity for marking shall be picofarads.

Numerical Value	Code
XX10 <sup>3</sup>	XX3
XX10 <sup>4</sup>	XX4
XX10 <sup>5</sup>	XX5
XX10 <sup>6</sup>	XX6
XX10 <sup>7</sup>	XX7

4.5.4.2 Tolerances

The tolerances on capacitance values shall be indicated by the letter code specified hereafter.

Tolerance ( $\pm$ %)	Code Letter
5.0	J
10	K
20	M



#### 4.5.4.3 Rated Voltage

The rated voltage shall be indicated by the code letters specified hereafter.

Rated Voltage (V)	Code Letter
50	C
100	E
160	F
250	H
630	Z

#### 4.5.5 Traceability Information

Traceability information shall be marked in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

#### 4.6 ELECTRICAL MEASUREMENTS

##### 4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C.

##### 4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3.

##### 4.6.3 Circuits for Electrical Measurements

Not applicable.

#### 4.7 BURN-IN TESTS

##### 4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at  $T_{amb} = +22 \pm 3$  °C. The parameter drift values ( $\Delta$ ) applicable to the parameters scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

##### 4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3006. The conditions for burn-in shall be as specified in Table 5 of this specification. On completion of burn-in, a recovery period of  $24 \pm 2$  hours is necessary before the end-measurements.

##### 4.7.3 Electrical Circuits for Burn-in (Figure 5)

Not applicable.

**TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE**

No.	Characteristics	Symbol	ESA/SCC 3006 Test Method	Test Condition	Limits		Unit
					Min.	Max.	
1	Capacitance	C	Para. 9.6.1.2	Test frequency: 1.0kHz	See Table 1(a) (Note 1)		$\mu\text{F}$
2	Tangent of Loss Angle	$Tg\delta$	Para. 9.6.1.3	Test frequency: 1.0kHz	-	10	$10^{-3}$
3	Insulation Resistance Terminal to Terminal	$R_i$	Para. 9.6.1.4	$C \leq 0.33\mu\text{F}$ $C > 0.33\mu\text{F}$	15 5000	- -	$\text{G}\Omega$ sec.
4	Insulation Resistance Terminals to Case	$R_{iB}$	Para. 9.6.1.4		15	-	$\text{G}\Omega$
5	Voltage Proof Terminal to Terminal	VP	Para. 9.6.1.1		$1.6 U_R$ (2)	-	V
6	Voltage Proof Terminals to Case	$VP_B$	Para. 9.6.1.1		$2.0 U_R$ (2)	-	V

**NOTES**

- ± Ordered Tolerance.
- For  $U_R$ , see Column 3 of Table 1(a). For  $VP_B$ , minimum 200V.

**TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES**

No.	Characteristics	Symbol	ESA/SCC 3006 Test Method	Test Condition (Note 1)	Limits		Unit
					Min.	Max.	
1(a)	Capacitance Change	$\frac{\Delta C}{C}$	Para. 9.6.1.2	$T_{amb} = -55^\circ\text{C}$ Test frequency: 1.0kHz	-	- 15 (2)	%
1(b)	Capacitance Change	$\frac{\Delta C}{C}$	Para. 9.6.1.2	$T_{amb} = +100^\circ\text{C}$ Test frequency: 1.0kHz	-	+ 8.0 (2)	%

**NOTES**

- These measurements shall be performed on a sample basis (see Para. 7.4.2 of ESA/SCC Generic Specification No. 3006). AQL: 1.0%.
- Related to value recorded at  $T_{amb} = +22^\circ\text{C}$ .

**FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS**

Not applicable.

**TABLE 4 - PARAMETER DRIFT VALUES**

No.	Characteristics	Symbol	Spec. and/or Test Method	Test Conditions	Change Limits ( $\Delta$ )	Unit
1	Capacitance Change	$\frac{\Delta C}{C}$	As per Table 2	As per Table 2	$\pm 3.0$	%

**TABLE 5 - CONDITIONS FOR BURN-IN AND OPERATING LIFE TESTS**

No.	Characteristic	Symbol	Condition	Unit
1	Ambient Temperature	$T_{amb}$	+ 85( + 0 - 5)	$^{\circ}C$
2	Test Voltage	$V_T$	1.25 $U_R$ (Note 1)	V

**NOTES**

- See Column 3 of Table 1(a)

**FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS**

Not applicable.

**4.8 ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC BASIC SPECIFICATION No. 3006)**

**4.8.1 Measurements and Inspections on Completion of Environmental Tests**

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3 \text{ }^{\circ}C$ .

**4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests**

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3 \text{ }^{\circ}C$ .

**4.8.3 Measurements and Inspections on Completion of Endurance Tests**

The parameters to be measured and inspections to be performed on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb} = +22 \pm 3 \text{ }^{\circ}C$ .

**4.8.4 Conditions for Operating Life Tests (Part of Endurance Testing)**

The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 3006. The conditions for operating life testing shall be as specified in Table 5 for the burn-in test.

**4.8.5 Electrical Circuits for Operating Life Tests (Figure 5)**

Not applicable.



**TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING**

NO.	ESA/SCC GENERIC SPEC. NO. 3006		MEASUREMENTS AND INSPECTIONS		SYMBOL	LIMITS		UNIT
	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS		MIN.	MAX.	
01	Seal Test (Hermetically Sealed)	Para. 9.2	Not applicable					
02	Rapid Change of Temperature	Para. 9.3.2	<b>Initial Measurements</b> Capacitance <b>Final Measurements</b> Visual Examination Capacitance Change Tangent of Loss Angle	Table 2 Item 1 After recovery of 24 ± 2 hours No damage Table 2 Item 1 Table 2 Item 2	C  ΔC/C Tgd	Record values  - 5.0 -	+ 15  + 5.0	%  10 <sup>-3</sup>
03	Corrosion (Hermetically Sealed)	Para. 9.8, Half without sleeving (2)	Not applicable					
04	Robustness of Terminations	Para. 9.9 and Para. 4.3.3 of this spec.	<b>Final Measurements</b> Visual Examination	No damage	-	-	-	
05	Resistance to Soldering Heat	Para. 9.10	<b>Initial Measurements</b> Capacitance <b>Final Measurements</b> Insulation Resistance Capacitance Change Tangent of Loss Angle	Table 2 Item 1 After recovery of 1 to 2 hrs Table 2 Item 3 Table 2 Item 1 Table 2 Item 2	C  Ri ΔC/C Tgd	Record values  Table 2 - 5.0 -	-  + 15 Table 2	%
06	Solderability	Para. 9.11 Method 3	<b>Final Measurements</b> Visual Examination	IEC No. 68-2-20 Para. 4.6.4, 4.7.4 or 4.9.3	-	-	-	
07	Vibration	Para. 9.12	<b>Measurements during Tests</b> During Last Cycle  <b>Final Measurements</b> Visual Examination	50% U <sub>R</sub> (3) applied  No intermittent contacts > 0.5ms or Open or Short Circuits  No evidence of damage	-  -	-  -	-  -	
08	Shock or Bump	Para. 9.13	<b>Measurements during Tests</b> During Last Cycle  <b>Final Measurements</b> Visual Examination	50% U <sub>R</sub> (3) applied  No intermittent contacts > 0.5ms or Open or Short Circuits  No evidence of damage, breakdown, arcing or fractures	-  -	-  -	-  -	

**NOTES**

1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.
2. If applicable
3. For U<sub>R</sub>, see Column 3 of Table 1(a). For VP<sub>B</sub>, minimum 200V.
4. Greater than 50% of the value given in Table 2.



**TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)**

NO.	ESA/SCC GENERIC SPEC. NO. 3006		MEASUREMENTS AND INSPECTIONS		SYMBOL	LIMITS		UNIT	
	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS		MIN.	MAX.		
09	Climatic Sequence	Para. 9.14	<b>Initial Measurements</b>	Table 2 Item 1 After recovery of 24 hrs max. No evidence of corrosion or unwrapping or mechanical damage to the sleeve ESA/SCC No. 3006 Para. 9.6.1.1 ESA/SCC No. 3006 Para. 9.6.1.4  After removal of sleeve (2) Table 2 Item 5 Table 2 Item 6 Table 2 Item 3 Table 2 Item 4 Table 2 Item 1 Table 2 Item 2	C	Record values			
			Capacitance		-	-			
			<b>Final Measurements</b>		-	-			
			Visual Examination		-	-			
			Voltage Proof (2)		VP <sub>S</sub>	4.0	-		kV
			Insulation Resistance (2)		Ri <sub>S</sub>	10	-		GΩ
			Voltage Proof		VP	2.0U <sub>R</sub> (3)	-		
			Voltage Proof		VP <sub>B</sub>	2.0U <sub>R</sub> (3)	-		
			Insulation Resistance		Ri	150	-		MΩ
Insulation Resistance	Ri <sub>B</sub>	50	-	sec.					
Capacitance Change	ΔC/C	5.0	-	GΩ					
Tangent of Loss Angle	Tgd	-5.0	+15	%					
							+5.0	10 <sup>-3</sup>	
10	Temperature Coefficient	Para. 9.15	<b>Final Measurements</b>	ESA/SCC No. 3006 Para. 9.15					
			Capacitance Change	Table 3 Item 1(a) Table 3 Item 1(b)	ΔC/C ΔC/C	- -	-15 +6.0	% %	
11	Operating Life	Para. 9.16 and Paras. 4.2.4 and 4.2.5 of this spec.	<b>Initial Measurements</b>	Table 2 Item 1 1.25U <sub>R</sub> (3)  After recovery of 24 ± 2 hours Table 2 Item 1 After removal of sleeves (2) and after 24 hrs recovery Table 2 Item 1 Table 2 Item 2 Table 2 Item 3 Table 2 Item 4 No evidence of damage or corrosion	C	Record values			
			Capacitance		-	-			
			<b>During Tests</b>		-	-			
			<b>Intermediate Measurements</b>		ΔC/C	-5.0	+15		%
			Capacitance Change		ΔC/C	-5.0	+15		%
			<b>Final Measurements</b>		Tgd	-	+5.0		10 <sup>-3</sup>
Capacitance Change	Ri	Note 4	-						
Tangent of Loss Angle	Tgd	-	+5.0						
Insulation Resistance	Ri	Note 4	-						
Insulation Resistance	Ri <sub>B</sub>	5.0	-	GΩ					
Visual Examination	-	-	-						
12	Permanence of Marking	Para. 9.17	<b>Final Measurements</b>	No corrosion or obliteration of marking	-	-	-		
			Visual Examination						

**NOTES:** See Page 15.